

L Number	Hits	Search Text	DB	Time stamp
1	1	kim with dea-yun.in.	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/22 07:58
2	5	hwang with jae-won.in.	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/22 08:00
3	1	kang with eun-ju.in.	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/22 08:00
4	7	749112.ap.	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/22 08:06
5	3	("5791969"   "6068539"   "6108091").PN.	USPAT	2004/07/22 08:04
6	1	6350179.URPN.	USPAT	2004/07/22 08:05
7	512	campbell with william.in.	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/22 08:07
8	20	campbell with jarrett with william.in.	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/22 08:07
12	7	("5653622"   "5655951"   "5665199"   "5696601"   "5730642"   "5827111"   "5865666").PN.	USPAT	2004/07/22 08:18
13	0	6171174.URPN.	USPAT	2004/07/22 08:18
17	4	("5643044"   "5658183"   "5664987"   "6077783").PN.	USPAT	2004/07/22 08:19
18	7	6213848.URPN.	USPAT	2004/07/22 08:19
-	1489	(451/5).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/22 07:58
-	810	(451/8).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 15:45
-	522	(451/57).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 15:45
-	825	(451/65).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 15:45
-	131	((451/5).CCLS.) and endpoint	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/14 14:53
-	127	((451/8).CCLS.) and endpoint	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/14 14:57
-	31826	chemical adj mechanical adj polishing	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/14 14:57
-	641	(chemical adj mechanical adj polishing) and endpoint and measur\$3 and control	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/14 15:03
-	186	((chemical adj mechanical adj polishing) and endpoint and measur\$3 and control) and measuring with thickness	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/14 15:04

-	3934	endpoint with detect\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 14:30
-	556	((endpoint with detect\$3) and thickness with measur\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 15:45
-	156	((endpoint with detect\$3) and thickness with measur\$3) and multiple with layer	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 14:32
-	1492	(451/5).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 15:45
-	814	(451/8).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 15:45
-	523	(451/57).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 15:45
-	825	(451/65).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 15:45
-	216	((451/5).CCLS.) and thickness with measur\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 16:14
-	172	((451/8).CCLS.) and thickness with measur\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 16:29
-	45	((451/57).CCLS.) and thickness with measur\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 16:31
-	20	((451/65).CCLS.) and thickness with measur\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 16:33
-	500	((endpoint with detect\$3) and thickness with measur\$3) and control\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT	2004/07/21 16:34